Search Notes



App	lica	tion	Contr	ol No
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Applicant(s)/Patent Under Reexamination

IWAMI ET AL.

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Art Unit

Dalena Tran

3664

SEARCHED

Class	Subclass	Date	Examiner
701	201, 209, 211	6/15/08	DT
340	995, 996	6/15/08	DT

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